Se	arch	Notes	•

Application/Control No.	Applicant(s)/Patent under Reexamination
09/853,684	TAKATA ET AL.
Examiner	Art Unit
Mai T. Tran	2121

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARCH	TES I STRATEGY)
	DATE	EXMR
Please see attached notes		